

## 3 mm Micro MATE-N-LOK\* Connector

## 1. INTRODUCTION

#### 1.1 Purpose

Testing was performed on 3 mm Micro MATE-N-LOK\* Connectors to determine its conformance related to the requirements of product specification 108-1836 Rev. E.

#### 1.2 Scope

This report covers the electrical, mechanical, and environmental performance of 3 mm Micro MATE-N-LOK\* Connectors. Testing was performed at the Shanghai Electrical Components Test Laboratory between May 29, 2018 and Aug.24, 2018. The associated test number is TP-18-01416.

#### **1.3 Conclusion**

Based on the test results, all meet the requirement.

#### **1.4 Test Specimens**

Specimens with the following part numbers as Table 1 were used for test, all wired specimens used 22AWG and 20AWG wire.

		Table 1					
Туре	Part No	Description	Qty.	Comments			
-	2315752-4	RECEPTACLE HOUSING, SINGLE ROW, MICRO MATE-N-LOK	E poiro/group				
	2315785-4	PLUG HOUSING, SINGLE ROW, FREE HANGING MICRO MATE-N-LOK	5 pairs/group	Only 2315752-4, 2315785-4, 3- 794617-0 and 3- 794615-0 are required to do group 5 test (glow wire test), and 2pcs/part no. for this test.			
2	2315752-4	RECEPTACLE HOUSING, SINGLE ROW, MICRO MATE-N-LOK	E paira/group				
2	2315786-4	PLUG HOUSING, SINGLE ROW, PANEL MOUNT, MICRO MATE-N-LOK	5 pairs/group				
3	3-794617-0	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK	E paira/group				
3	3-794615-0	PLUG HOUSING, 2 TO 24 POSITION DUAL ROW, PANEL MOUNT, MICRO MATE-N-LOK	5 pairs/group				
4	3-794617-0	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK	E poiro/group				
	3-794616-0	PLUG HOUSING, 2 TO 24 POSITION DUAL ROW, FREE HANGING, MICRO MATE-N-LOK	5 pairs/group				

Besides list above, the following list below also must be considered as approved although not tested. Part numbers have variation of polarization (poka-yoke) and number of ways, but they use the same raw material and are contained in the same product line.



PN	Description
3-794615-6	PLUG HOUSING, 2 TO 24 POSITION DUAL ROW, PANEL MOUNT, MICRO MATE-N-LOK
3-794615-8	PLUG HOUSING, 2 TO 24 POSITION DUAL ROW, PANEL MOUNT, MICRO MATE-N-LOK
3-794616-6	PLUG HOUSING, 2 TO 24 POSITION DUAL ROW, FREE HANGING, MICRO MATE-N-LOK
3-794616-8	PLUG HOUSING, 2 TO 24 POSITION DUAL ROW, FREE HANGING, MICRO MATE-N-LOK
3-794617-2	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK
3-794617-4	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK
3-794617-6	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK
3-794617-8	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK
4-794617-2	RECEPTACLE HOUSING, 2 TO 24 POSITION, DUAL ROW, MICRO MATE-N-LOK
2-1445022-3	RECEPTACLE HOUSING, 2 TO 12 POSITION, SINGLE ROW, MICRO MATE-N-LOK
2-1445022-6	RECEPTACLE HOUSING, 2 TO 12 POSITION, SINGLE ROW, MICRO MATE-N-LOK
2315744-2	RECEPTACLE HOUSING, DUAL ROW, MICRO MATE-N-LOK
2315744-4	RECEPTACLE HOUSING, DUAL ROW, MICRO MATE-N-LOK
2315752-2	RECEPTACLE HOUSING, SINGLE ROW, MICRO MATE-N-LOK
2315752-3	RECEPTACLE HOUSING, SINGLE ROW, MICRO MATE-N-LOK
2315758-2	PLUG HOUSING, DUAL ROW, PANEL MOUNT, MICRO MATE-N-LOK
2315758-4	PLUG HOUSING, DUAL ROW, PANEL MOUNT, MICRO MATE-N-LOK
2315759-2	PLUG HOUSING, DUAL ROW, FREE HANGING, MICRO MATE-N-LOK
2315759-4	PLUG HOUSING, DUAL ROW, FREE HANGING, MICRO MATE-N-LOK
2315785-2	PLUG HOUSING, SINGLE ROW, FREE HANGING MICRO MATE-N-LOK
2315785-3	PLUG HOUSING, SINGLE ROW, FREE HANGING MICRO MATE-N-LOK
2315786-2	PLUG HOUSING, SINGLE ROW, PANEL MOUNT, MICRO MATE-N-LOK
2315786-3	PLUG HOUSING, SINGLE ROW, PANEL MOUNT, MICRO MATE-N-LOK

## 1.5 Test Sequence

		Test Group							
Test	1	2	3	4	5				
	Test Sequence								
Examination of Product	1,9	1,8	1,8	1	1				
Termination resistance	3,7	2,6							
Insulation resistance			2,6						
Dielectric withstanding			3,7						
Temperature rise vs current		3,7							
Temperature rise									
Vibration, random	5								
Mechanical shock	6								
Durability	4	2							
Mating force	2		2						
Unmating force	8								
Housing lock strength				5					
Thermal shock			4	3					
Humidity/temperature cycling			5	4					
Temperature life		5							
Mixed flowing gas		4							
Crimp contact retention			9						
Glow wire end-products test					2				
Crimp contact insertion force				2					

Table 2





a). Test group defined per customer requirement

b). Numbers indicate sequence in which tests are performed.

### 1.6 Environmental Conditions

Unless otherwise stated, the following environmental conditions prevailed during testing: Temperature: 15°C to 35°C Relative Humidity: 25% to 75%

# 2. TEST PROCEDUES

### 2.1. Examination of Product

Visual Inspection: appearance, and function of specimens pursuant to the applicable inspection plan. Requirements: Meets requirements of product drawing and no physical damage. Test Method: EIA-364-18 B

#### 2.2. Termination resistance

Subject specimens to 100 milliamperes maximum and 20 millivolts maximum open circuit voltage. Requirements: 20 m $\Omega$  Max. Test Method: IEC 60512-2-1-2002

#### 2.3. Insulation Resistance

Test between adjacent contacts of mated specimens with 500 V DC for 2 minutes. Requirements: 1000M $\Omega$ . Min (initial); 500M $\Omega$ . Min (final) Test Method: EIA-364-21E

#### 2.4. Dielectric withstanding

1500 volts AC at sea level. Test between adjacent contacts of mated specimens. 1 minute hold with no breakdown, flashover, or 0.5 milliampere maximum leakage. Requirements: No breakdown or flashover. Test Method: EIA-364 20D

#### 2.5. Temperature rise

Stabilize at a single current level until 3 readings at 5 minutes intervals are within 1°C. Test current: 5A DC for 4 Pos. 4.25A DC for 10 Pos. All wired specimens used 20 AWG wire for this group. Requirements: 30 °C Max. Test Method: EIA-364-70C, Method 1.

#### 2.6. Vibration, random

Subject mated specimens to 3.10 G's rms between 20-500 Hz. 15 minutes in each of 3 mutually perpendicular planes. Requirements: No discontinuities of 1 microsecond or longer duration. Test Method: EIA-364-28F, Test Condition VII, Condition D

#### 2.7. Mechanical shock

Subject mated specimens to 50 G's half-sine shock pulses of 11 milliseconds duration. 3 shocks in each direction applied along 3 mutually perpendicular planes, 18total shocks. Requirements: No discontinuities of 1 microsecond or longer duration. Test Method: EIA-364-27C, Method A



## 2.8. Durability

Mate and unmated specimens for 30 cycles for tin plated specimens, 75 cycles for 15 μin gold plated specimens, and 150 cycles for 30 μin gold plated specimens at a maximum rate of 500 cycles per hour. Requirements: no physical damage. Test Method: EIA-364-9C

2.9. Mating force&unmating

Measure the force necessary to mate and unmated samples with a rate of 5.08 mm /min.Requirements:Mating force4 Pos. 27.44 N Max. (0.7kgf\*4\*9.8=27.44N, 0.7kgf Max. per contact);10 Pos. 68.60 N Max. (0.7kgf\*10\*9.8=68.60, 0.7kgf Max. per contact);4 Pos. 2.74 N Min. (0.07kgf\*4\*9.8=2.74N, 0.07kgf Min. per contact);10 Pos. 6.86 N Min. (0.07kgf\*10\*9.8=6.86N, 0.07kgf Min. per contact);10 Pos. 6.86 N Min. (0.07kgf\*10\*9.8=6.86N, 0.07kgf Min. per contact);

Test Method: EIA-364-13E-2011

## 2.10. Housing Locking Strength

Determine housing lock strength at a maximum rate of 12.7 mm per minute. Requirements: 26.46 N Min. Test Method: EIA-364-98-1997

## 2.11. Thermal shock

Mated connector -40°C/30 min., 105°C/30 min. Making this a cycle, repeat 5 cycles. Requirements: No physical damage. Test Method: EIA-364-32G

## 2.12. Humidity/temperature cycling

Subject specimens to 10 cycles (10 days) between 25 and 65°C at 80 to 100% RH. Requirements: No visible defects or deviations, no cracks on the isolating parts. Test Method: EIA-364-31E-2017, Method III.

## 2.13. Temperature life

Subject mated specimens to 105°C for 500 hours. Requirements: No visible defects or deviations, no cracks on the isolating parts. Test Method: EIA-364-17C, Method A.

## 2.14. Mixed flowing gas

Subject mated specimens to environmental Class IIA for 20 days (30°C and 70%R.H., Cl2 10ppb, NO2 200ppb, H2S 10ppb, SO2 100ppb). Requirements: No physical damage and meet requirement of subsequent test. Test Method: EIA-364-65, Class IIA.

## 2.15. Crimp contact retention

Apply an axial load of 1.81 kgf to contacts at a rate of 0.45 kgf per second and hold for 6 seconds. Requirements: Contact shall not dislodge. Test Method: EIA-364-29C.

## 2.16. Glow wire end-products test

The extremity of the wire is positioned horizontally and brought into contact with the sample with a force between 0.85 and 1.2N for a period of 30s. Test temperature: 750℃ Time of Glow tip application Ta: 30s Requirements: Te-Ti ≤2s or no flame Test Method: IEC 60335-1 edition 5.2 2016-05.



## 2.17. Crimp contact insertion force

Measure force necessary to insert crimped contacts into housing. Requirements: 6.86 N Max. Test Method: 108-1836 Rev.E.

# 3. SUMMARY OF TESTING

Group	Test Item	QTY	Condition	Test				Dequirement	Constructor	
				Max	Min	Ave	Unit	Requirement	Conclusion	
	Examination of Product	20	initial	No physical damage occurred			/	No abnormalities	Meet spec	
		5	Initial-type1	17.88	13.19	14.46	N	27.44 N Max.	Maatanaa	
	Mating force	5	Initial-type2	25.26	11.91	18.89	IN	27.44 N Wax.		
	Mating force	5	Initial-type3	46.16	32.84	37.33	N	68.60 N Max.	Meet spec	
		5	Initial-type4	39.04	26.01	32.97	IN	00.00 IN IVIAX.		
		5	Initial-type1	5.37	3.66	4.24				
	Termination resistance	5	Initial-type2	9.23	5.18	7.21	mΩ	20 mΩ Max. Mee	Meet spec	
	Termination resistance	5	Initial-type3	6.85	3.85	4.53	11112			
1		5	Initial-type4	5.28	3.79	4.56				
I	Durability	20	final	No physical damage occurred			/	No abnormalities	Meet spec	
	Vibration, random	20	final	No physical damage, no electrical discontinuity greater than 1 µs			/	No abnormalities	Meet spec	
	Mechanical shock	20	final	No physical damage, no electrical discontinuity greater than 1 µs			/	No abnormalities	Meet spec	
		5	final-type1	14.10	4.22	7.82				
		5	final-type2	16.58	4.74	10.09		20 mΩ Max.	Meet spec	
	Termination resistance	5	final-type3	11.73	4.09	5.99	mΩ	$20 \text{ m}\Omega$ wax.		
		5	final-type4	13.93	4.19	6.95				
		5	final-type1	8.88	7.91	7.34	NI	0.74 NLM		
	l lana atina da kan	5	final-type2	3.63	3.01	3.20	N	2.74 N Min.	Maatanaa	
	Unmating force	5	final-type3	13.06	10.06	12.08	N		Meet spec	
		5	final-type4	14.97	10.28	12.52	N	6.86 N Min.		
	Examination of Product	20	final	No physical damage occurred		/	No abnormalities	Meet spec		

Crown	Test Item	QTY	Condition	Test Result				Dequirement	Conclusion
Group	Test Item		Condition	Max	Min	Ave	Unit	Requirement	Conclusion
	Examination of Product	20	initial	No physic	cal damage	occurred.	/	No abnormalities	Meet spec
		5	Initial-type1	4.89	3.63	4.14			
	Termination resistance	5	Initial-type2	4.75	4.75	3.89	mΩ	20 mΩ Max.	Meet spec
	rennination resistance	5	Initial-type3	5.30	2.54	4.23	11152	20 msz wax.	Meet spec
		5	Initial-type4	5.50	3.41	4.25			
		5	Initial-type1	20.22	15.55	18.00			
	Temperature rise vs	5	Initial-type2	19.55	13.84	16.40	°C	30 °C Max.	Meet spec
	current	5	Initial-type3	23.18	19.39	21.09			Meet Spec
		5	Initial-type4	23.99	19.13	21.47			
2	Mixed flowing gas	20	final	No physi	cal damage	occurred	/	No abnormalities	Meet spec
	Temperature life	20	final		cal damage		/	No abnormalities	Meet spec
		5	final-type1	7.67	3.86	5.20	4		
	Termination resistance	5	final-type2	8.05	4.21	5.53	mΩ	20 mΩ Max.	Meet spec
		5	final-type3	7.59	4.16	5.14		_0 11132 WIGA.	moor spoo
		5	final-type4	8.30	4.26	5.24			
	Temperature rise vs current	5	final-type1	22.31	16.60	18.98	_	30 °C Max.	Meet spec
		5	final-type2	23.77	18.14	20.23	°C		
		5	final-type3	25.11	20.20	22.54	_		
		5	final-type4	23.97	20.49	22.04			
	Examination of Product	20	final	No physical damage occurred			/	No abnormalities	Meet spec
	Examination of Product	20	initial	No physical damage occurred		/	No abnormalities	Meet spec	
	Crimp contact insertion force	5	Initial-type1	5.33	1.27	3.32	_	6.86 N Max.	Meet spec
		5	Initial-type2	5.73	1.07	3.49	N		
		5	Initial-type3	5.54	1.39	3.52	_		
		5	Initial-type4	5.42	1.60	3.58			
		5 5	Initial-type1	3.73	0.55	1.45 1.12	-		
	Insulation resistance		Initial-type2	1.66	0.54		10 <sup>11</sup> Ω	1000 MΩ Min.	Meet spec
		5 5	Initial-type3 Initial-type4	<u>1.57</u> 4.19	0.60	0.97	-		
	Dielectric withstanding	20	initial		4.19 0.73 0.97 No breakdown, no flashover		/	No abnormalities	Meet spec
3	Thermal shock	20	final	No physi	cal damage	occurred	/	No abnormalities	Meet spec
	Humidity/temperature cycling	20	final	No physi	cal damage	occurred	/	No abnormalities	Meet spec
		5	final-type1	4.40	1.85	3.04		<u></u>	
		5	final-type2	5.26	2.37	3.32	10105	500 140 14	
	Insulation resistance	5	final-type3	4.40	1.17	1.91	10 <sup>10</sup> Ω	500 MΩ Min.	Meet spec
		5	final-type4	3.00	1.24	1.93	1		
	Dielectric withstanding	20	final		No breakdown, no flashover		/	No abnormalities	Meet spec
	Examination of Product	20	final	No physical damage occurred			/	No abnormalities	Meet spec
	Crimp contact retention	20	final	Contact	Contact were not dislodged.			Contact shall not dislodge	Meet spec

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Group	Test Item	QTY	Condition	Test Result				Requirement	Conclusion
Group	Test item	QIT	Condition	Max	Min	Ave	Unit	nequirement	Conclusion
	Examination of Product	20	initial	No physical damage occurred			/	No abnormalities	Meet spec
	Thermal shock	20	initial	No physical damage occurred			/	No abnormalities	Meet spec
4	Humidity/temperature cycling	20	final	No physical damage occurred			/	No abnormalities	Meet spec
	Housing lock strength	5	final-type1	34.02	32.58	33.28	- N	26.46 N Min	Meet spec
		5	final-type2	34.14	33.67	33.99			
		5	final-type3	32.81	30.86	32.23			
		5	final-type4	38.92	34.09	35.50			
5	Examination of Product	8	initial	No physical damage occurred			/	No abnormalities	Meet spec
	Glow wire end-products test	8	final	No flame			/	Te-Ti ≤2s or no flame	Meet spec

Note: 1 kgf=9.8 N; 100 MΩ=108 Ω.

## 4. CALIBRATION

## 4.1 Calibration Statement

All equipment containing a calibration number is calibrated and traceable through TE Connectivity (TE).

# 5. VALIDATION

Requested by:				
	Jyotirmaya	2018	05	18
		/	/	
Product Engineer TE Connectivity In	dia Pvt Ltd.			
Prepared by:				
	Xuewei Liao	2018	09	14
		/	/	
Test Engineer Shanghai Electrica	l Components Test Lab.			
Approved by:				
	Robin Lu	2018	09	14
		/	/	
Manager Shanghai Electrica	al Components Test Lab			

Shanghai Electrical Components Test Lab.